Application No.: 10/017,942 Docket No.: 37310-000178/US

## Listing of Claims and Amendments thereto:

This listing of claims will replace all prior versions, and listings, of claims in the application:

1. (Currently Amended) A method of packaging electronic devices <u>that operate based on acoustic waves</u>, comprising the steps of:

providing a cap wafer having a surface;

lithographically forming raised ridges on the cap wafer surface at areas near a perimeter of a desired cavity region so that the raised ridges are a contiguous part of said cap waferforming raised ridges on the cap water wafer surface;

printing a glass frit material on the raised ridges; and

bonding, <u>via said glass frit material</u> at each raised ridge, <u>said-the</u> cap wafer surface to a substrate surface containing electronic devices,

each raised ridge using surface tension to hold the glass frit to a higher and thinner frit line width dimension, and to prevent lateral flow of the glass frit, than if the frit were deposited directly on a flat cap wafer surface without lithographically formed raised ridges.

- 2. (Cancel) The method of claim 1, wherein said step of forming further includes lithographically forming said raised ridges at areas near the perimeter of a desired cavity region, so that said raised ridges are a contiguous part of said cap wafer.
- 3. (Cancel) The method of claim 2, wherein each raised ridge is formed slightly inboard from the perimeter of a desired cavity region, each raised ridge having glass frit material printed thereon for bonding said cap wafer to said substrate.
- 4. (Cancel) The method of claim 3, wherein each raised ridge is configured so as to utilize surface tension to hold the glass frit into a higher and thinner frit linewidth dimension, and prevent lateral flow of the low-viscosity frit, then if the frit were deposited directly on a flat cap wafer surface without lithographically formed raised ridges.

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5. (Original) The method of claim 4, wherein a linewidth of the frit is less than 125  $\mu$ m.

6. (Cancel) The method of claim 3, wherein said raised ridges are fabricated to any desired height, width and location on said cap wafer surface.

- 7. (Currently Amended) The method of claim 1, wherein bonding areas when the raised ridges are bonded form a continuous perimeter around the device, so that a hermetic seal is formed.
- 8. (Currently Amended) A method of packaging electronic devices operating based on acoustic waves, comprising the steps of:

providing a cap wafer having a surface;

The method of claim 1, said step of forming further including the steps of:

trenching recesses into said-the cap wafer surface at areas near the perimeter of a desired cavity region;

printing material into said-the recesses and planarizing it such that each filled recess is flush with the cap wafer surface; and

etching away the cap wafer surface, except for the areas of the original recesses, so that the material forms the raised ridges that are bonded to the substrate surface.

- 9. (Currently Amended) The method of claim 8, wherein each raised ridge is formed slightly inboard from the perimeter of a desired cavity region, each raised ridge composed of a glass frit material for bonding said-the cap wafer to said-the substrate.
- 10. (Original) The method of claim 9, wherein a linewidth of the frit is less than 125  $\mu$ m.
- 11. (Currently Amended) The method of claim 8, wherein, after said-the recesses are formed and the recesses are filled, said-the raised ridges are fabricated to any desired height, width and location on said cap wafer surface by etching the surrounding cap wafer surface surrounding each filled recess.

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12. (Original) The method of claim 8 wherein the ridges form a continuous perimeter around a cavity region such that a hermetic seal is made when the cap wafer is bonded to a wafer of an electronic device.